

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WANG ET AL.	
		10/785,445	Examiner	Art Unit
		Matthew D. Matzek	1771	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0096083	05-2003	Morgan et al.	428/141
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NON-PATENT DOCUMENTS

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